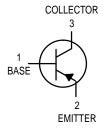
Switching Transistor PNP Silicon



MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--------------------------------|------------------|-------|------|
| Collector-Emitter Voltage | VCEO | -40 | Vdc |
| Collector-Base Voltage | V _{СВО} | -40 | Vdc |
| Emitter-Base Voltage | VEBO | -5.0 | Vdc |
| Collector Current — Continuous | IC | -600 | mAdc |

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Max | Unit | |
|---|-----------------------------------|-------------|-------|--|
| Total Device Dissipation FR-5 Board ⁽¹⁾ | PD | 225 | mW | |
| T _A = 25°C Derate above 25°C | | 1.8 | mW/°C | |
| Thermal Resistance, Junction to Ambient | $R_{\theta JA}$ | 556 | °C/W | |
| Total Device Dissipation Alumina Substrate, (2) T _A = 25°C | PD | 300 | mW | |
| Derate above 25°C | | 2.4 | mW/°C | |
| Thermal Resistance, Junction to Ambient | $R_{	heta JA}$ | 417 | °C/W | |
| Junction and Storage Temperature | T _J , T _{stg} | -55 to +150 | °C | |

DEVICE MARKING

MMBT4403LT1 = 2T

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

| Characteristic | Symbol | Min | Max | Unit |
|---|----------|------|------|------|
| OFF CHARACTERISTICS | | | • | |
| Collector-Emitter Breakdown Voltage(3) (I _C = -1.0 mAdc, I _B = 0) | V(BR)CEO | -40 | _ | Vdc |
| Collector-Base Breakdown Voltage (IC = -0.1 mAdc, IE = 0) | V(BR)CBO | -40 | _ | Vdc |
| Emitter-Base Breakdown Voltage (IE = -0.1 mAdc, IC = 0) | V(BR)EBO | -5.0 | _ | Vdc |
| Base Cutoff Current (V _{CE} = -35 Vdc, V _{EB} = -0.4 Vdc) | IBEV | _ | -0.1 | μAdc |
| Collector Cutoff Current (VCE = -35 Vdc, VEB = -0.4 Vdc) | ICEX | _ | -0.1 | μAdc |

- 1. FR-5 = $1.0 \times 0.75 \times 0.062$ in.
- 2. Alumina = 0.4 \times 0.3 \times 0.024 in. 99.5% alumina.
- 3. Pulse Test: Pulse Width \leq 300 $\mu s,$ Duty Cycle \leq 2.0%.

Thermal Clad is a trademark of the Bergquist Company.

Preferred devices are Motorola recommended choices for future use and best overall value.

MMBT4403LT1

Motorola Preferred Device



CASE 318-08, STYLE 6 SOT-23 (TO-236AB)



ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted) (Continued)

| Characteristic | | Symbol | Min | Max | Unit |
|---|---|-----------------|------------------------------|---------------------|--------------------|
| ON CHARACTERISTICS | | • | | | |
| $\label{eq:DC Current Gain} \begin{array}{l} \text{DC Current Gain} \\ \text{(I}_{\text{C}} = -0.1 \text{ mAdc, V}_{\text{CE}} = -1.0 \text{ Vdc)} \\ \text{(I}_{\text{C}} = -1.0 \text{ mAdc, V}_{\text{CE}} = -1.0 \text{ Vdc)} \\ \text{(I}_{\text{C}} = -10 \text{ mAdc, V}_{\text{CE}} = -1.0 \text{ Vdc)} \\ \text{(I}_{\text{C}} = -150 \text{ mAdc, V}_{\text{CE}} = -2.0 \text{ Vdc)} \\ \text{(I}_{\text{C}} = -500 \text{ mAdc, V}_{\text{CE}} = -2.0 \text{ Vdc)} \\ \end{array}$ | | hFE | 30 60 100 100 20 | 300 | _ |
| Collector – Emitter Saturation Voltage ⁽³⁾ (I _C = -150 mAdc, I _B = -15 mAdc) (I _C = -500 mAdc, I _B = -50 mAdc) | | VCE(sat) | | -0.4 -0.75 | Vdc |
| Base-Emitter Saturation Voltage (3) (I _C = -150 mAdc, I _B = -15 mAdc) (I _C = -500 mAdc, I _B = -50 mAdc) | | VBE(sat) | -0.75 | -0.95 -1.3 | Vdc |
| SMALL-SIGNAL CHARACTERISTICS | | | | | |
| Current-Gain — Bandwidth Product (I _C = -20 mAdc, V _{CE} = -10 Vdc, f = 100 M | ИHz) | fT | 200 | _ | MHz |
| Collector–Base Capacitance (V _{CB} = -10 Vdc, I _E = 0, f = 1.0 MHz) | | C _{cb} | _ | 8.5 | pF |
| Emitter–Base Capacitance (V _{BE} = -0.5 Vdc, I _C = 0, f = 1.0 MHz) | | C _{eb} | _ | 30 | pF |
| Input Impedance (I _C = -1.0 mAdc, V _{CE} = -10 Vdc, f = 1.0 k | tHz) | h _{ie} | 1.5 | 15 | kΩ |
| Voltage Feedback Ratio (I _C = -1.0 mAdc, V _{CE} = -10 Vdc, f = 1.0 k | :Hz) | h _{re} | 0.1 | 8.0 | X 10 ⁻⁴ |
| Small-Signal Current Gain (IC = -1.0 mAdc, VCE = -10 Vdc, f = 1.0 k | :Hz) | h _{fe} | 60 | 500 | _ |
| Output Admittance (I _C = -1.0 mAdc, V _{CE} = -10 Vdc, f = 1.0 k | (Hz) | h _{oe} | 1.0 | 100 | μmhos |
| SWITCHING CHARACTERISTICS | | | | | |
| Delay Time | $(V_{CC} = -30 \text{ Vdc}, V_{EB} = -2.0 \text{ Vdc}, I_{C} = -150 \text{ mAdc}, I_{B1} = -15 \text{ mAdc})$ | t _d | _ | 15 | ns |
| Rise Time | | t _r | _ | 20 | |
| Storage Time | $(V_{CC} = -30 \text{ Vdc}, I_{C} = -150 \text{ mAdc}, I_{B1} = I_{B2} = -15 \text{ mAdc})$ | t _S | _ | 225 | ns |
| Fall Time | | tf | _ | 30 | 110 |

^{3.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

SWITCHING TIME EQUIVALENT TEST CIRCUIT

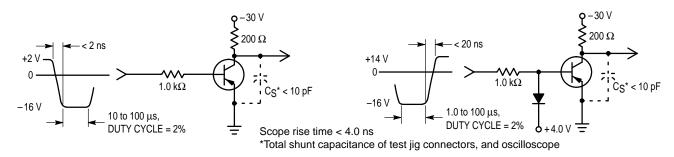


Figure 1. Turn-On Time

Figure 2. Turn-Off Time

TRANSIENT CHARACTERISTICS

- 25°C

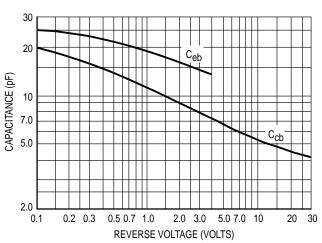


Figure 3. Capacitances

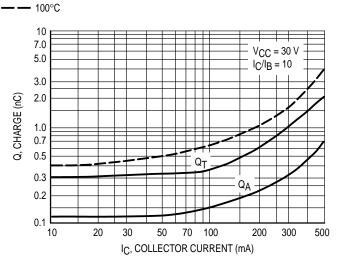


Figure 4. Charge Data

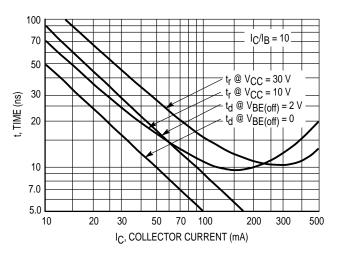


Figure 5. Turn-On Time

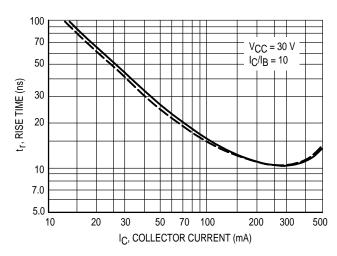


Figure 6. Rise Time

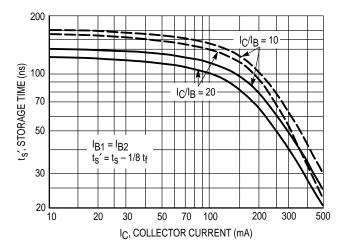
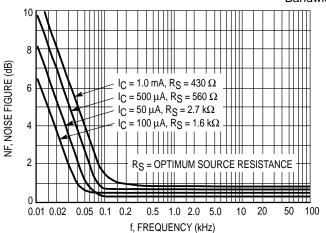


Figure 7. Storage Time

SMALL-SIGNAL CHARACTERISTICS **NOISE FIGURE**

 $V_{CE} = -10 \text{ Vdc}, T_A = 25^{\circ}\text{C}$ Bandwidth = 1.0 Hz



NF, NOISE FIGURE (dB) $I_C = 50 \mu A$ 100 μΑ 500 μΑ 1.0 mA 200 100 10 k 50 k 50 RS, SOURCE RESISTANCE (OHMS)

Figure 8. Frequency Effects

Figure 9. Source Resistance Effects

h PARAMETERS

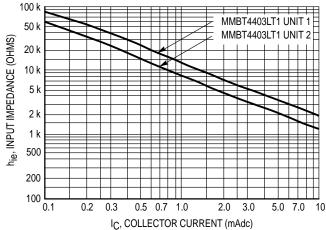
 $V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}, T_A = 25^{\circ}\text{C}$

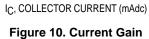
This group of graphs illustrates the relationship between hfe and other "h" parameters for this series of transistors. To obtain these curves, a high-gain and a low-gain unit were

700 500 h_{fe}, CURRENT GAIN 300 200 MMBT4403LT1 UNIT 1

were used to develop the correspondingly-numbered curves on each graph. 100 k

selected from the MMBT4403LT1 lines, and the same units





2.0

0.5 0.7 1.0

MMBT4403LT1 UNIT 2

5.0 7.0 10

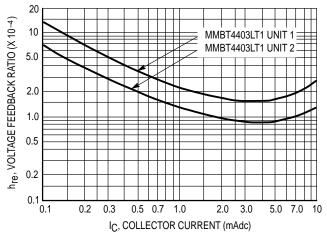


Figure 12. Voltage Feedback Ratio

Figure 11. Input Impedance

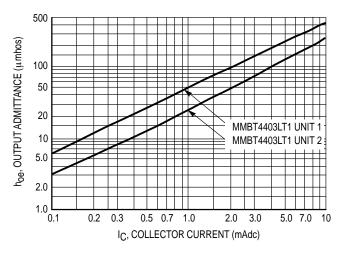


Figure 13. Output Admittance

100

70

50

30

0.2

STATIC CHARACTERISTICS

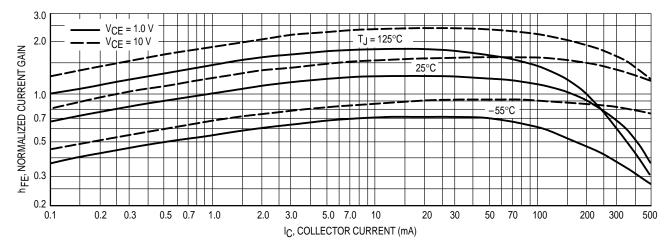


Figure 14. DC Current Gain

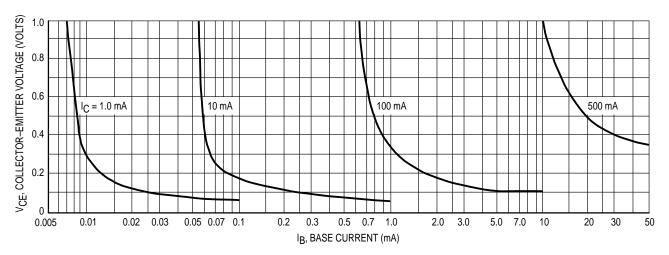


Figure 15. Collector Saturation Region

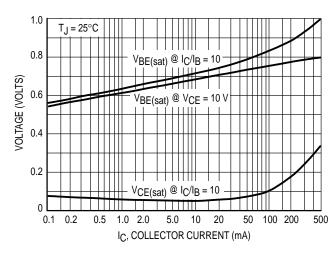


Figure 16. "On" Voltages

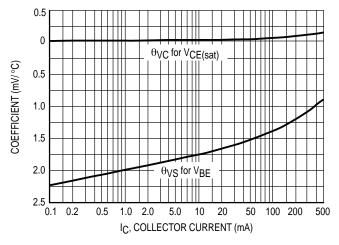
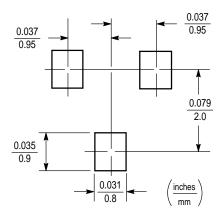


Figure 17. Temperature Coefficients

INFORMATION FOR USING THE SOT-23 SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



SOT-23

SOT-23 POWER DISSIPATION

The power dissipation of the SOT–23 is a function of the pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A . Using the values provided on the data sheet for the SOT–23 package, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta,JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of $25^{\circ}C$, one can calculate the power dissipation of the device which in this case is 225 milliwatts.

$$P_D = \frac{150^{\circ}C - 25^{\circ}C}{556^{\circ}C/W} = 225 \text{ milliwatts}$$

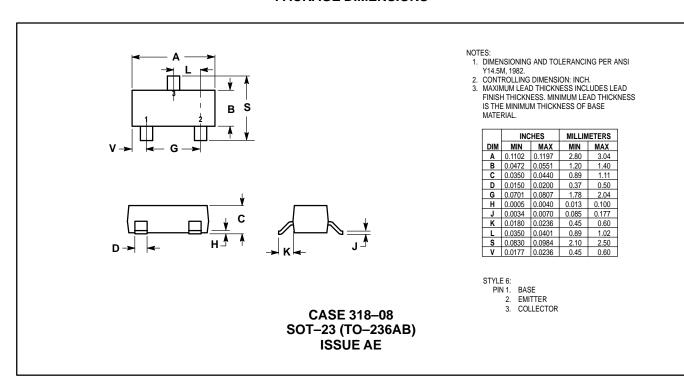
The 556°C/W for the SOT–23 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 225 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT–23 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes.
 Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.
- * Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

PACKAGE DIMENSIONS



MMBT4403LT1

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